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| Notice of References Cited | Application/Control No. 10/708,873 | Applicant(s)/Patent Under Reexamination CHENG, STEVEN D. | |
| | Examiner Bryan J. Fox | Art Unit 2686 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| | A | US-2005/0148316 A1 | 07-2005 | Laatu, Juho | 455/404.1 |
| | B | US-6,070,065 A | 05-2000 | Armbruster et al. | 455/404.2 |
| | C | US-2001/0044302 A1 | 11-2001 | Okuyama, Toshiyuki | 455/432 |
| | D | US-6,011,967 A | 01-2000 | Wieck, Christopher P. | 455/404.1 |
| | E | US-6,633,754 B1 | 10-2003 | Raith, Alex K. | 455/404.1 |
| | F | US-2002/0065063 A1 | 05-2002 | UHLIK et al. | 455/404 |
| | G | US-2004/0185824 A1 | 09-2004 | Cheng, Steven D. | 455/404.2 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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